

# Simulation of HTS Josephson mixers

Colin Pegrum, Ting Zhang, Jia Du and Yingjie Jay Guo

**Abstract**—CSIRO has developed superconducting Microwave Monolithic Integrated Circuit (MMIC) mixers using step-edge Josephson junctions and on-chip filters, made from YBaCuO on MgO substrates. Integration into a MMIC results in a compact and efficiently-coupled structure. These have been shown to have outstanding conversion efficiency, dynamic range and linearity.

We report here a range of simulations of this type of mixer. We have mainly used Josephson simulators and analyse the data in both the time and frequency domains. More recently we also use microwave simulators incorporating a novel Verilog-A Josephson junction model that we have developed. We have looked at the interactions of junction bias current, local oscillator power and RF input power with conversion efficiency, dynamic range and linearity. Good agreement is found overall with measurements.

**Index Terms**—MMIC, Superconducting microwave devices, Josephson mixers, heterodyning.

## I. INTRODUCTION

CSIRO has recently demonstrated a range of single-junction externally-pumped mixers, which use an HTS step-edge junction [1], [2], a radio-frequency (RF) input bandpass filter (BPF), a low-pass filter (LPF) at the output intermediate frequency (IF) and a transmission-line resonator for the local oscillator (LO) input (which stops RF leakage back into the LO port). All components are integrated as a Monolithic Microwave Integrated Circuit (MMIC) on a single MgO substrate. This results in a compact and efficiently-coupled structure. Details about the CSIRO HTS step-edge junction technology can be found in [1] and [2]. The filter design and performance is described in [3]–[5].

First-generation devices operated typically at 7 to 12 GHz [6]–[8] and recently a 30 to 33 GHz Ka device been reported [9]. Fig. 1 shows a packaged MMIC with a 10–12 GHz BPF, a 4 GHz cut-off LPF and an 8 GHz LO filter [6]. The simulation results reported here relate to this device.

## II. MODELLING APPROACHES

We model the MMIC mixer in two different ways. The first uses Agilent’s Advanced Design System (ADS) [10], a powerful microwave design and simulation package. The second is based on the well-trying and freely-available Josephson simulator JSIM [11], [12] with various custom post-processing routines.

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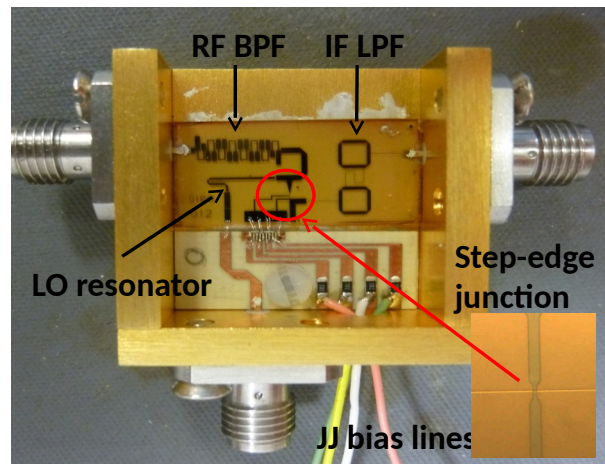


Fig. 1. Photo of a packaged HTS MMIC, with 10 – 12 GHz input and 8 GHz LO, taken from [6]. The MgO substrate is 10 mm  $\times$  20 mm. The inset shows the 2  $\mu$ m wide step-edge junction.

### A. Agilent Advanced Design System (ADS)

ADS can simulate accurate models of the various microwave filters in the MMIC. But as supplied it has no built-in model for a Josephson junction, so we have adapted a Verilog-A model from [13] and imported this into ADS. Preliminary results have been reported recently elsewhere [14] and agree well with experimental measurements. The Verilog-A model has also been separately tested using the Qucs simulator [15] and a Josephson junction, just with DC bias: its time-domain results agree precisely with those from JSIM. (Qucs also has a wide range of microstrip components, and filter design packages, but these are only supported in the frequency domain in its present version, so Qucs cannot be used currently for our time-domain simulations.)

This paper reports work using the JSIM approach.

### B. JSIM

JSIM has only a simple transmission line model, so it is not possible to use it to represent the complex microstrip filters used in the MMIC. Initially we designed instead 50  $\Omega$  band-pass and low-pass filters using discrete inductors, capacitors and resistors. But there are two serious issues with this approach: the out-of-band impedances of these filters are very different to those of the real microstrip filters, so the broadband behaviour will not be representative; also, the large number of components needed to get high-order filters causes JSIM to run unacceptably slowly.

So instead we simplified the model to the minimum possible, as in Fig. 2. This uses AC current sources for the RF and LO inputs. Current sources have infinite impedance, so

they provide perfect mutual isolation. We expect this simplified model to show the maximum conversion efficiency possible: it has no filter losses, and there are no mismatch issues between the filters and the low-resistance junction.

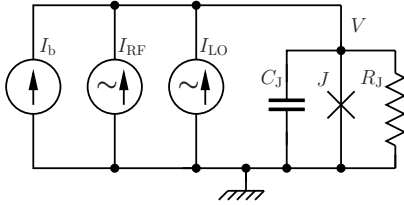


Fig. 2. Our simplified JSIM mixer model. The junction has a DC current source for bias  $I_b$ . AC current sources  $I_{RF}$  and  $I_{LO}$  provide RF and LO inputs.

For all of the simulations reported here, the critical current  $I_c = 774 \mu\text{A}$ , the junction resistance  $R_J = 2.5 \Omega$ , its  $C_J = 18 \text{ fF}$  [16], and the simulation temperature  $T = 40 \text{ K}$  in most cases. The RF, LO and IF frequencies  $f_{RF}$ ,  $f_{LO}$  and  $f_{IF}$  are 10.4, 8 and 2.4 GHz respectively. All these parameters match those of the experimental device [6], so we can compare simulation and experiment. In addition, we have modelled mixers with quite different junction characteristics, e.g.  $I_c = 100 \mu\text{A}$ ,  $R_J = 20 \Omega$ , which match the experimental results in [7]. Those results (none are shown here) are qualitatively the same. Note that the latter junction is hysteretic with no RF or LO drive, but with LO turned on, the hysteresis is suppressed.

### III. OUTLINE OF THE SIMULATION PROCEDURE

JSIM time-domain data for the mixer output voltage  $V(t)$  was generated by parallel processing on a 4 or 8 core CPU. The power spectral density (PSD) of  $V(t)$  was got by an Octave or Matlab post-processing script using the `pwelch` function, with sampling rates and durations set for adequate frequency and amplitude resolution. A typical mixer PSD at  $T = 40 \text{ K}$  is shown in Fig. 3. The script locates spectral peaks around the RF, LO and IF frequencies in the PSD, using the built-in `findpeaks` function, with an adaptive amplitude threshold detector, and measures their powers  $P_{RF}$ ,  $P_{LO}$  and  $P_{IF}$  and the conversion efficiency  $\eta = P_{IF}/P_{RF}$ . The dynamic resistance  $R_d = V_{RF}/I_{RF}$  is also estimated from the voltage amplitude  $V_{RF}$  of the RF signal from the PSD. The correct normalisation factors are applied [17] for the Hanning window used, and the amplitude and power calibration was confirmed by a test circuit with the junction replaced by just a resistor.

### IV. CRITICAL CURRENT SUPPRESSION

We looked first at current-voltage ( $I$ - $V$ ) characteristics and the dependence of  $I_c(I_{LO})$  on the LO amplitude  $I_{LO}$ , with no RF input, Figs. 4(a) and (b). We found the  $I_c$  suppression varies very linearly with LO amplitude:

$$I_c(I_{LO}) = I_c(0) - I_{LO} \quad (1)$$

as shown in Fig. 4(b). This linearity is also seen in our experimental measurements, Figs. 5(a) and (b), for this single-junction mixer [6]. We saw this previously [18]. We find also that  $I_c(I_{LO})$  remains fully suppressed for  $I_{LO} > I_c(0)$ , both

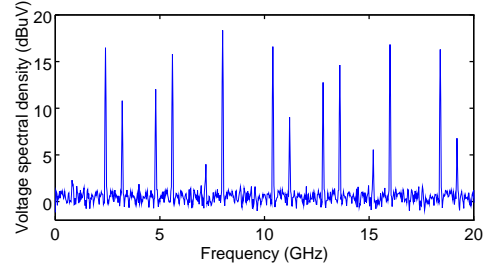


Fig. 3. A typical spectrum, for  $f_{RF} = 10.4 \text{ GHz}$  and  $f_{LO} = 8 \text{ GHz}$ . Mixing of harmonics of  $f_{RF}$  and  $f_{LO}$  generates the extra peaks in addition to  $f_{IF} = 2.4 \text{ GHz}$ .

in simulation and experiment. This departure from the Bessel-like response expected for a voltage-driven junction is because the junction is current-driven, and also because the Josephson frequency  $f_J \approx 900 \text{ GHz} \gg f_{LO}$  [19].

From Figs. 4(b) and 5(a) we can relate the experimental LO power to the LO current amplitude in the simulation; e.g. an LO power of  $-40 \text{ dB}$  is equivalent to a LO amplitude of  $302 \mu\text{A}$ .

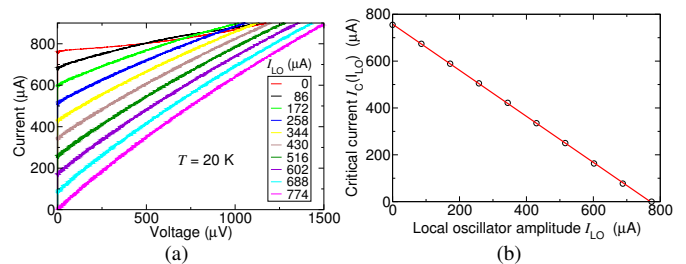


Fig. 4. Simulation data, (a) a set of  $I$ - $V$  curves for increasing  $I_{LO}$ ; (b) the critical current suppression is a linear function of  $I_{LO}$ .

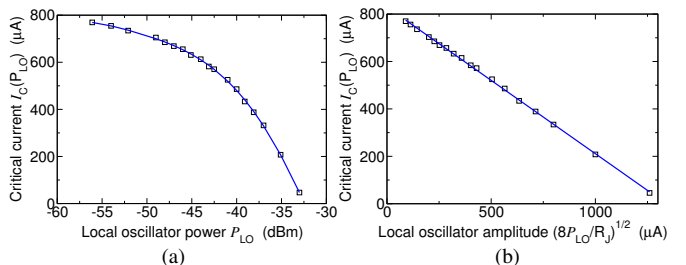


Fig. 5. Experimental data at  $T = 40 \text{ K}$  for the critical current (a) as a function LO power (b) showing its linear dependence on the LO voltage. Data from [6].

### V. EFFECTS OF NOISE

Most experimental measurements were done at  $T = 40 \text{ K}$ . At this temperature the junction noise-rounding parameter  $\Gamma(I_c) = (2\pi k_B T)/(I_c \Phi_0) \approx 2 \times 10^{-3}$  for  $I_c = 774 \mu\text{A}$  and therefore thermal noise has little effect on the  $I$ - $V$  characteristics in the absence of RF or LO input.

In simulations at  $T = 0 \text{ K}$ , with LO input at 8 GHz at typical levels, microwave-induced steps can be seen, as in Fig. 6. Their step height  $\Delta I_c \approx 10 \mu\text{A}$  and since  $\Gamma(10 \mu\text{A}) = 0.17$  at 40 K, these steps are strongly noise-rounded and so we find they are neither visible experimentally at 40 K [6], nor in the simulation in Fig. 4(a) at 20 K.

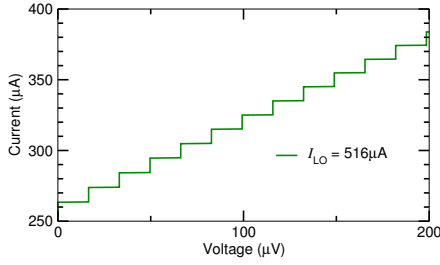


Fig. 6. Part of a simulated  $I$ - $V$  curve for  $I_c = 774 \mu\text{A}$  at  $T = 0 \text{ K}$ , with  $f_{\text{LO}} = 8 \text{ GHz}$ .

For the simulations described below in Sections VI and VII we ran some trials at  $T = 0, 20$  and  $40 \text{ K}$ . The results for all were broadly the same and the difference between the  $20 \text{ K}$  and  $40 \text{ K}$  results was not significant. Because simulations at  $20 \text{ K}$  are faster than those at  $40 \text{ K}$ , for the same signal-to-noise ratio, we ran some at  $20 \text{ K}$ , but unless shown otherwise, all results here are at  $T = 40 \text{ K}$ .

## VI. DEPENDENCE ON RF AND LO AMPLITUDES

We have looked at the variations of IF output and conversion efficiency with DC bias current  $I_b$ , for a very wide range of LO and RF currents  $I_{\text{LO}}$  and  $I_{\text{RF}}$ . Some representative results are shown in Figs. 7(a) and (b). It shows that  $\eta$  can be as high as  $-1 \text{ dB}$ , which is in line with experimental measurements of  $-1 \text{ dB}$  at  $20 \text{ K}$  and  $-3.6 \text{ dB}$  at  $40 \text{ K}$  [6], both of which take into account filter losses and input and output coupling losses in the real MMIC.

A notable feature is a minimum in IF output at a certain value of  $I_b$ ; this is also seen in experiments, as in Fig. 7(c). We [6] and others [20] have previously attributed this to a point of inflection in the  $I$ - $V$  curve. We would expect this to be at the bias current where  $R_d$  is a maximum. The simulation results in Fig. 8 show that there is indeed a single maximum in  $R_d$ , and like the location of the  $V_{\text{IF}}$  minimum, it moves to higher  $I_b$  with increasing  $I_{\text{LO}}$ , however, it appears that the minimum in  $V_{\text{IF}}$  does not quite coincide with the maximum in our estimate of  $R_d$ . This issue needs further consideration.

## VII. LINEARITY

The procedure of Section III was adapted to study the linearity of the MMIC, by varying  $I_{\text{RF}}$  for a range of values of  $I_{\text{LO}}$ . Simulated dependencies on  $I_{\text{RF}}$  of the IF output  $V_{\text{IF}}$  and the conversion efficiency  $\eta$  are shown in Figs. 9(a) and (b), for  $I_b = 700 \mu\text{A}$ .

We see that  $\eta$  is constant and the output varies linearly with input, up to the point where  $I_{\text{RF}} \approx I_{\text{LO}}$ . Beyond that, there is a linear fall in output, followed by a rapid collapse in the output at high values of  $I_{\text{RF}}$ . Broadly similar features are seen experimentally, as in Fig. 9(c), which shows the behaviour for just one value of  $P_{\text{LO}}$  [6].

## VIII. CONCLUSIONS

1. We believe our simulation method is effective, economical and fast, with results which agree well with experiment.
2. In this ideal model, the best conversion efficiency seen was  $-1 \text{ dB}$  for optimum values of  $I_b \approx 500 \mu\text{A}$  and

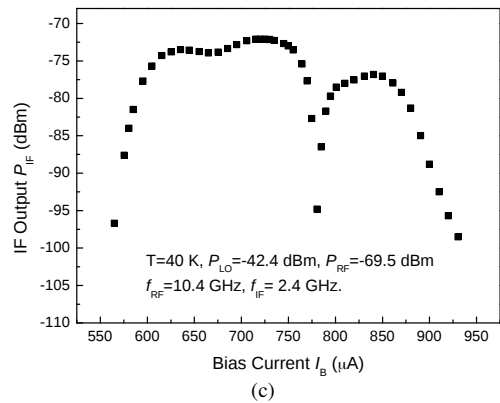
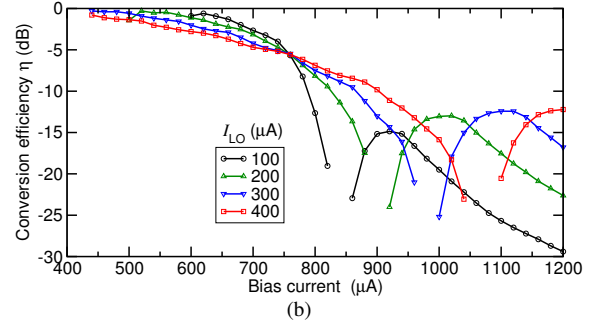
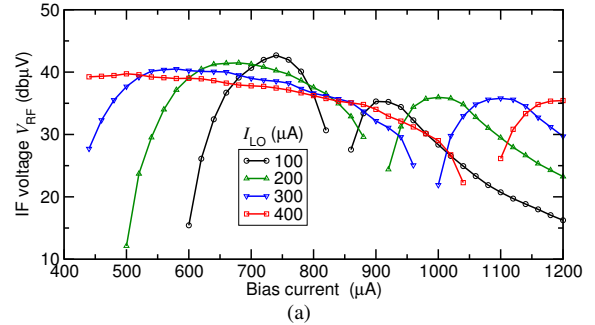


Fig. 7. (a) Simulated IF power and (b) simulated conversion efficiency, as functions of bias current  $I_b$ , at  $T = 40 \text{ K}$ , for  $I_{\text{RF}} = 80 \mu\text{A}$ . Discontinuities in the data occur where the IF output falls below the noise level and an accurate measure of it cannot be made. (c) Experimental IF power dependence on  $I_b$ , also showing a sharp minimum, taken from [6].

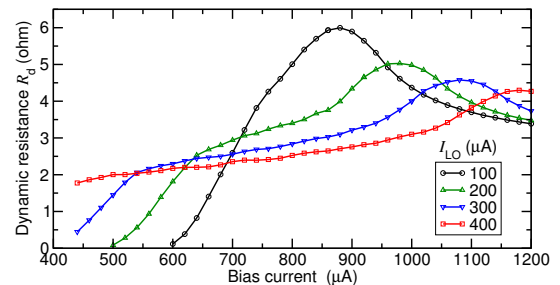


Fig. 8. Estimated dynamic resistance  $R_d$ , from simulation at  $T = 40 \text{ K}$ , for  $I_{\text{RF}} = 80 \mu\text{A}$ .

$I_{\text{LO}} = 200 \mu\text{A}$ . The optimum operating range is with  $I_b$  well below  $I_c$ , which is always well clear of the point of zero IF output.

3. We find the same dependence of critical current suppression on LO amplitude as we see in experiments. The dependence is linear, and for  $I_{\text{LO}} > I_c(0)$ ,  $I_c(I_{\text{LO}}) = 0$ .

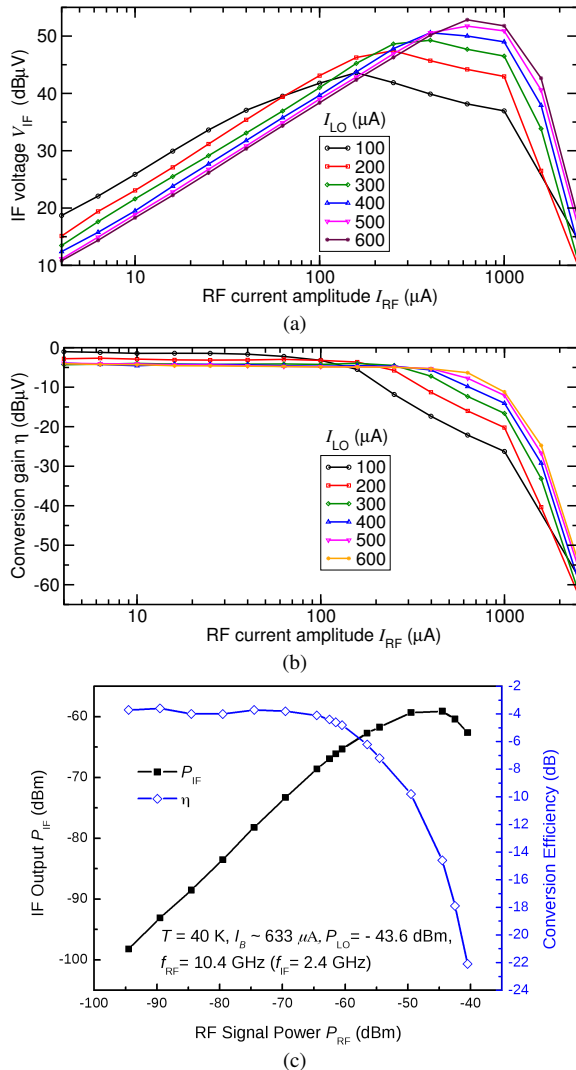


Fig. 9. (a) Simulated IF output voltage amplitude as a function of RF current amplitude, for a range of values of  $I_{LO}$ , (b) A similar plot for simulated conversion efficiency  $\eta$ . (c) Experimental data for  $P_{IF}$  and  $\eta$ , as a function of RF power  $P_{RF}$ , taken from [6].

4. Best linearity is obtained with high LO drive, but the best conversion efficiency is with low LO drive.
5. The minimum in IF output at a certain value of  $I_b$ , seen in both experiments and simulations, needs further study; it is not clear why other mixing products do not disappear at this same bias point.

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